日本材料学会九州支部特別講演会のお知らせ

台湾の National Cheng Kung University (国立成功大学)の Prof. Tz-Cheng Chiu の来日に合わせ、大分大学にて、下記のように特別講演会を開催致します。

皆様、奮ってご参加ください。

記

日時: 令和6年10月3日(金)10:00~11:30

場所: 大分大学旦野原キャンパス 理工9号館1階多目的研修室

(〒870-1192 大分市旦野原 700 番地)

講演者: Prof. Tz-Cheng Chiu

(Department of Mechanical Engineering, National Cheng Kung University)

講演題目: Application of Fracture Mechanics in the Mechanical Reliability of Interfaces in Advanced Microelectronic Components

アブストラクト:

Driven by the needs in high performance computing and artificial intelligence applications, advanced 2.5-D microelectronic packaging technology based on Si chiplets is currently under rapid development. The 2.5-D integration scheme typically uses either polymer-dielectric based redistribution layer (RDL) or silicon interposer-based interconnect for allowing fast electrical connection between the logic processor and the high-bandwidth memory (HBM). From the structural perspective, a common feature of the 2.5-D package is the vast amount of materials interfaces such as Si-epoxy molding compound (EMC), Si-underfill, Cu-polyimide (PI). Because of the intrinsically weak adhesions of these interfaces, debonding crack growth during fabrication and in-use conditions is one of the critical failure modes of the advanced 2.5-D package. Quantitative estimations of the interface adhesion and the crack growth driving force are therefore essential for considering the risk of debonding failure. In this presentation, fracture mechanics based experimental-numerical procedures for evaluating the debonding risks of materials interfaces are discussed. Topics including vapor-pressure driven pop-corning failure under solder reflow process and viscoelastic and viscoplastic deformations of the RDL interconnect structure on the energy absorptions during debond growth are discussed after a brief overview of the theoretical backgrounds.

以上

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